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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded - Microcontrollers</u>"

Details	
Product Status	Obsolete
Core Processor	CIP-51 8051
Core Size	8-Bit
Speed	72MHz
Connectivity	I ² C, SMBus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	28
Program Memory Size	16KB (16K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	1.25K x 8
Voltage - Supply (Vcc/Vdd)	2.2V ~ 3.6V
Data Converters	A/D 20x14b; D/A 2x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	32-TQFP
Supplier Device Package	32-QFP (7x7)
Purchase URL	https://www.e-xfl.com/product-detail/silicon-labs/efm8lb11f16e-b-qfp32r

1. Feature List

The EFM8LB1 device family are fully integrated, mixed-signal system-on-a-chip MCUs. Highlighted features are listed below.

- · Core:
 - Pipelined CIP-51 Core
 - · Fully compatible with standard 8051 instruction set
 - · 70% of instructions execute in 1-2 clock cycles
 - · 72 MHz maximum operating frequency
- · Memory:
 - Up to 64 kB flash memory (63 kB user-accessible), in-system re-programmable from firmware in 512-byte sectors
 - Up to 4352 bytes RAM (including 256 bytes standard 8051 RAM and 4096 bytes on-chip XRAM)
- · Power:
 - · Internal LDO regulator for CPU core voltage
 - · Power-on reset circuit and brownout detectors
- I/O: Up to 29 total multifunction I/O pins:
 - · Up to 25 pins 5 V tolerant under bias
 - · Selectable state retention through reset events
 - · Flexible peripheral crossbar for peripheral routing
 - 5 mA source, 12.5 mA sink allows direct drive of LEDs
- · Clock Sources:
 - Internal 72 MHz oscillator with accuracy of ±2%
 - Internal 24.5 MHz oscillator with ±2% accuracy
 - Internal 80 kHz low-frequency oscillator
 - · External CMOS clock option
 - External crystal/RC oscillator (up to 25 MHz)

- · Analog:
 - 14/12/10-Bit Analog-to-Digital Converter (ADC)
 - Internal calibrated temperature sensor (±3 °C)
 - 4 x 12-Bit Digital-to-Analog Converters (DAC)
 - 2 x Low-current analog comparators with adjustable reference
- · Communications and Digital Peripherals:
 - 2 x UART, up to 3 Mbaud
 - SPI™ Master / Slave, up to 12 Mbps
 - SMBus™/I2C™ Master / Slave, up to 400 kbps
 - I²C High-Speed Slave, up to 3.4 Mbps
 - 16-bit CRC unit, supporting automatic CRC of flash at 256byte boundaries
 - · 4 Configurable Logic Units
- · Timers/Counters and PWM:
 - 6-channel Programmable Counter Array (PCA) supporting PWM, capture/compare, and frequency output modes
 - · 6 x 16-bit general-purpose timers
 - Independent watchdog timer, clocked from the low frequency oscillator
- · On-Chip, Non-Intrusive Debugging
 - · Full memory and register inspection
 - · Four hardware breakpoints, single-stepping
- · Pre-programmed UART or SMBus bootloader

With on-chip power-on reset, voltage supply monitor, watchdog timer, and clock oscillator, the EFM8LB1 devices are truly standalone system-on-a-chip solutions. The flash memory is reprogrammable in-circuit, providing nonvolatile data storage and allowing field upgrades of the firmware. The on-chip debugging interface (C2) allows non-intrusive (uses no on-chip resources), full speed, in-circuit debugging using the production MCU installed in the final application. This debug logic supports inspection and modification of memory and registers, setting breakpoints, single stepping, and run and halt commands. All analog and digital peripherals are fully functional while debugging. Device operation is specified from 2.2 V up to a 3.6 V supply. Devices are AEC-Q100 qualified (pending) and available in 4x4 mm 32-pin QFN, 3x3 mm 24-pin QFN, 32-pin QFP, or 24-pin QSOP packages. All package options are lead-free and RoHS compliant.

Ordering Part Number	Flash Memory (kB)	RAM (Bytes)	Digital Port I/Os (Total)	ADC0 Channels	Voltage DACs	Comparator 0 Inputs	Comparator 1 Inputs	Bootloader Type	Pb-free (RoHS Compliant)	Temperature Range	Package
EFM8LB12F64E-B-QSOP24	64	4352	21	13	4	6	7	UART	Yes	-40 to +105 °C	QSOP24
EFM8LB12F64ES0-B-QFN32	64	4352	29	20	4	10	9	SMBus	Yes	-40 to +105 °C	QFN32
EFM8LB12F64ES0-B-QFN24	64	4352	20	12	4	6	6	SMBus	Yes	-40 to +105 °C	QFN24
EFM8LB12F32E-B-QFN32	32	2304	29	20	4	10	9	UART	Yes	-40 to +105 °C	QFN32
EFM8LB12F32E-B-QFP32	32	2304	28	20	4	10	9	UART	Yes	-40 to +105 °C	QFP32
EFM8LB12F32E-B-QFN24	32	2304	20	12	4	6	6	UART	Yes	-40 to +105 °C	QFN24
EFM8LB12F32E-B-QSOP24	32	2304	21	13	4	6	7	UART	Yes	-40 to +105 °C	QSOP24
EFM8LB12F32ES0-B-QFN32	32	2304	29	20	4	10	9	SMBus	Yes	-40 to +105 °C	QFN32
EFM8LB12F32ES0-B-QFN24	32	2304	20	12	4	6	6	SMBus	Yes	-40 to +105 °C	QFN24
EFM8LB11F32E-B-QFN32	32	2304	29	20	21	10	9	UART	Yes	-40 to +105 °C	QFN32
EFM8LB11F32E-B-QFP32	32	2304	28	20	2 ¹	10	9	UART	Yes	-40 to +105 °C	QFP32
EFM8LB11F32E-B-QFN24	32	2304	20	12	2 ¹	6	6	UART	Yes	-40 to +105 °C	QFN24
EFM8LB11F32E-B-QSOP24	32	2304	21	13	2 ¹	6	7	UART	Yes	-40 to +105 °C	QSOP24
EFM8LB11F32ES0-B-QFN32	32	2304	29	20	2 ¹	10	9	SMBus	Yes	-40 to +105 °C	QFN32
EFM8LB11F32ES0-B-QFN24	32	2304	20	12	2 ¹	6	6	SMBus	Yes	-40 to +105 °C	QFN24
EFM8LB11F16E-B-QFN32	16	1280	29	20	2 ¹	10	9	UART	Yes	-40 to +105 °C	QFN32
EFM8LB11F16E-B-QFP32	16	1280	28	20	2 ¹	10	9	UART	Yes	-40 to +105 °C	QFP32
EFM8LB11F16E-B-QFN24	16	1280	20	12	2 ¹	6	6	UART	Yes	-40 to +105 °C	QFN24
EFM8LB11F16E-B-QSOP24	16	1280	21	13	2 ¹	6	7	UART	Yes	-40 to +105 °C	QSOP24
EFM8LB11F16ES0-B-QFN32	16	1280	29	20	2 ¹	10	9	SMBus	Yes	-40 to +105 °C	QFN32
EFM8LB11F16ES0-B-QFN24	16	1280	20	12	2 ¹	6	6	SMBus	Yes	-40 to +105 °C	QFN24
EFM8LB10F16E-B-QFN32	16	1280	29	20	0	10	9	UART	Yes	-40 to +105 °C	QFN32
EFM8LB10F16E-B-QFP32	16	1280	28	20	0	10	9	UART	Yes	-40 to +105 °C	QFP32
EFM8LB10F16E-B-QFN24	16	1280	20	12	0	6	6	UART	Yes	-40 to +105 °C	QFN24
EFM8LB10F16E-B-QSOP24	16	1280	21	13	0	6	7	UART	Yes	-40 to +105 °C	QSOP24
EFM8LB10F16ES0-B-QFN32	16	1280	29	20	0	10	9	SMBus	Yes	-40 to +105 °C	QFN32
EFM8LB10F16ES0-B-QFN24	16	1280	20	12	0	6	6	SMBus	Yes	-40 to +105 °C	QFN24

Note:

1. DAC0 and DAC1 are enabled on devices with 2 DACs available.

3.4 Clocking

The CPU core and peripheral subsystem may be clocked by both internal and external oscillator resources. By default, the system clock comes up running from the 24.5 MHz oscillator divided by 8.

The clock control system offers the following features:

- Provides clock to core and peripherals.
- 24.5 MHz internal oscillator (HFOSC0), accurate to ±2% over supply and temperature corners.
- 72 MHz internal oscillator (HFOSC1), accurate to ±2% over supply and temperature corners.
- 80 kHz low-frequency oscillator (LFOSC0).
- · External RC, CMOS, and high-frequency crystal clock options (EXTCLK).
- · Clock divider with eight settings for flexible clock scaling:
 - Divide the selected clock source by 1, 2, 4, 8, 16, 32, 64, or 128.
 - · HFOSC0 and HFOSC1 include 1.5x pre-scalers for further flexibility.

3.5 Counters/Timers and PWM

Programmable Counter Array (PCA0)

The programmable counter array (PCA) provides multiple channels of enhanced timer and PWM functionality while requiring less CPU intervention than standard counter/timers. The PCA consists of a dedicated 16-bit counter/timer and one 16-bit capture/compare module for each channel. The counter/timer is driven by a programmable timebase that has flexible external and internal clocking options. Each capture/compare module may be configured to operate independently in one of five modes: Edge-Triggered Capture, Software Timer, High-Speed Output, Frequency Output, or Pulse-Width Modulated (PWM) Output. Each capture/compare module has its own associated I/O line (CEXn) which is routed through the crossbar to port I/O when enabled.

- · 16-bit time base
- · Programmable clock divisor and clock source selection
- Up to six independently-configurable channels
- 8, 9, 10, 11 and 16-bit PWM modes (center or edge-aligned operation)
- · Output polarity control
- · Frequency output mode
- · Capture on rising, falling or any edge
- · Compare function for arbitrary waveform generation
- · Software timer (internal compare) mode
- · Can accept hardware "kill" signal from comparator 0 or comparator 1

Universal Asynchronous Receiver/Transmitter (UART1)

UART1 is an asynchronous, full duplex serial port offering a variety of data formatting options. A dedicated baud rate generator with a 16-bit timer and selectable prescaler is included, which can generate a wide range of baud rates. A received data FIFO allows UART1 to receive multiple bytes before data is lost and an overflow occurs.

UART1 provides the following features:

- · Asynchronous transmissions and receptions
- · Dedicated baud rate generator supports baud rates up to SYSCLK/2 (transmit) or SYSCLK/8 (receive)
- 5, 6, 7, 8, or 9 bit data
- · Automatic start and stop generation
- · Automatic parity generation and checking
- · Single-byte buffer on transmit and receive
- · Auto-baud detection
- · LIN break and sync field detection
- · CTS / RTS hardware flow control

Serial Peripheral Interface (SPI0)

The serial peripheral interface (SPI) module provides access to a flexible, full-duplex synchronous serial bus. The SPI can operate as a master or slave device in both 3-wire or 4-wire modes, and supports multiple masters and slaves on a single SPI bus. The slave-select (NSS) signal can be configured as an input to select the SPI in slave mode, or to disable master mode operation in a multi-master environment, avoiding contention on the SPI bus when more than one master attempts simultaneous data transfers. NSS can also be configured as a firmware-controlled chip-select output in master mode, or disabled to reduce the number of pins required. Additional general purpose port I/O pins can be used to select multiple slave devices in master mode.

- · Supports 3- or 4-wire master or slave modes
- · Supports external clock frequencies up to 12 Mbps in master or slave mode
- · Support for all clock phase and polarity modes
- 8-bit programmable clock rate (master)
- Programmable receive timeout (slave)
- · Two byte FIFO on transmit and receive
- Can operate in suspend or snooze modes and wake the CPU on reception of a byte
- Support for multiple masters on the same data lines

System Management Bus / I2C (SMB0)

The SMBus I/O interface is a two-wire, bi-directional serial bus. The SMBus is compliant with the System Management Bus Specification, version 1.1, and compatible with the I^2C serial bus.

The SMBus module includes the following features:

- · Standard (up to 100 kbps) and Fast (400 kbps) transfer speeds
- · Support for master, slave, and multi-master modes
- · Hardware synchronization and arbitration for multi-master mode
- · Clock low extending (clock stretching) to interface with faster masters
- Hardware support for 7-bit slave and general call address recognition
- · Firmware support for 10-bit slave address decoding
- · Ability to inhibit all slave states
- · Programmable data setup/hold times
- Transmit and receive FIFOs (one byte) to help increase throughput in faster applications

4. Electrical Specifications

4.1 Electrical Characteristics

All electrical parameters in all tables are specified under the conditions listed in Table 4.1 Recommended Operating Conditions on page 14, unless stated otherwise.

4.1.1 Recommended Operating Conditions

Table 4.1. Recommended Operating Conditions

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Operating Supply Voltage on VDD	V_{DD}		2.2	_	3.6	V
Operating Supply Voltage on VIO ^{2,}	V _{IO}		2.2	_	V _{DD}	V
System Clock Frequency	f _{SYSCLK}		0	_	73.5	MHz
Operating Ambient Temperature	T _A		-40	_	105	°C

Note:

- 1. All voltages with respect to GND
- 2. In certain package configurations, the VIO and VDD supplies are bonded to the same pin.
- 3. GPIO levels are undefined whenever VIO is less than 1 V.

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
ADC0 ⁴	I _{ADC}	High Speed Mode	_	1275	1700	μA
		1 Msps, 12-bit conversions				
		Normal bias settings				
		V _{DD} = 3.0 V				
		Low Power Mode	_	390	530	μA
		350 ksps, 12-bit conversions				
		Low power bias settings				
		V _{DD} = 3.0 V				
Internal ADC0 Reference ⁵	I _{VREFFS}	High Speed Mode	_	700	790	μA
		Low Power Mode	_	170	210	μA
On-chip Precision Reference	I _{VREFP}		_	75	_	μA
Temperature Sensor	I _{TSENSE}		_	68	120	μA
Digital-to-Analog Converters (DAC0, DAC1, DAC2, DAC3) ⁶	I _{DAC}		_	125	_	μA
Comparators (CMP0, CMP1)	I _{CMP}	CPMD = 11	_	0.5	_	μA
		CPMD = 10	_	3	_	μA
		CPMD = 01	_	10	_	μA
		CPMD = 00	_	25	_	μA
Comparator Reference	I _{CPREF}		_	24	_	μA
Voltage Supply Monitor (VMON0)	I _{VMON}		_	15	20	μA

Note:

- 1. Currents are additive. For example, where I_{DD} is specified and the mode is not mutually exclusive, enabling the functions increases supply current by the specified amount.
- 2. Includes supply current from internal LDO regulator, supply monitor, and High Frequency Oscillator.
- 3. Includes supply current from internal LDO regulator, supply monitor, and Low Frequency Oscillator.
- 4. ADC0 power excludes internal reference supply current.
- 5. The internal reference is enabled as-needed when operating the ADC in low power mode. Total ADC + Reference current will depend on sampling rate.
- 6. DAC supply current for each enabled DA and not including external load on pin.

4.1.7 External Clock Input

Table 4.7. External Clock Input

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
External Input CMOS Clock	f _{CMOS}		0	_	50	MHz
Frequency (at EXTCLK pin)						
External Input CMOS Clock High Time	t _{CMOSH}		9	_	_	ns
External Input CMOS Clock Low Time	t _{CMOSL}		9	_	_	ns

4.1.8 Crystal Oscillator

Table 4.8. Crystal Oscillator

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Crystal Frequency	f _{XTAL}		0.02	_	25	MHz
Crystal Drive Current	I _{XTAL}	XFCN = 0	_	0.5	_	μΑ
		XFCN = 1	_	1.5	_	μΑ
		XFCN = 2	_	4.8	_	μА
		XFCN = 3	_	14	_	μА
		XFCN = 4	_	40	_	μΑ
		XFCN = 5	_	120	_	μΑ
		XFCN = 6	_	550	_	μΑ
		XFCN = 7	_	2.6	_	mA

4.1.9 ADC

Table 4.9. ADC

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit		
Resolution	N _{bits}	14 Bit Mode		14		Bits		
		12 Bit Mode		12		Bits		
		10 Bit Mode		10				
Throughput Rate	f _S	14 Bit Mode	_	_	900	ksps		
(High Speed Mode)		12 Bit Mode	_	_	1	Msps		
		10 Bit Mode	_	_	1.125	Msps		
Throughput Rate	f_S	14 Bit Mode	_	_	320	ksps		
(Low Power Mode)		12 Bit Mode	_	_	340	ksps		
		10 Bit Mode	_	_	360	ksps		
Tracking Time	t _{TRK}	High Speed Mode	217.8 ¹	_	_	ns		
		Low Power Mode	450	_	_	ns		
Power-On Time	t _{PWR}		1.2	_	_	μs		
SAR Clock Frequency	f _{SAR}	High Speed Mode	_	_	18.36	MHz		
		Low Power Mode	_	_	12.25	MHz		
Conversion Time ²	t _{CNV}	14-Bit Conversion,		0.81		μs		
		SAR Clock =18 MHz,						
		System Clock = 72 MHz.						
		12-Bit Conversion,		0.7				
		SAR Clock =18 MHz,						
		System Clock = 72 MHz.						
		10-Bit Conversion,		0.59				
		SAR Clock =18 MHz,						
		System Clock = 72 MHz.						
Sample/Hold Capacitor	C _{SAR}	Gain = 1	_	5.2	_	pF		
		Gain = 0.75	_	3.9	_	pF		
		Gain = 0.5	_	2.6	_	pF		
		Gain = 0.25	_	1.3	_	pF		
Input Pin Capacitance	C _{IN}	High Quality Input	_	20	_	pF		
		Normal Input	_	20	_	pF		
Input Mux Impedance	R _{MUX}	High Quality Input	_	330	_	Ω		
		Normal Input	_	550	_	Ω		
Voltage Reference Range	V _{REF}		1	_	V _{IO}	V		
Input Voltage Range ³	V _{IN}		0	_	V _{REF} / Gain	V		

4.1.10 Voltage Reference

Table 4.10. Voltage Reference

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Internal Fast Settling Reference						
Output Voltage	V _{REFFS}		1.62	1.65	1.68	V
(Full Temperature and Supply Range)						
Temperature Coefficient	TC _{REFFS}		_	50	_	ppm/°C
Turn-on Time	t _{REFFS}		_	_	1.5	μs
Power Supply Rejection	PSRR _{REF} FS		_	400	_	ppm/V
On-chip Precision Reference						
Valid Supply Range	V_{DD}	1.2 V Output	2.2	_	3.6	V
		2.4 V Output	2.7	_	3.6	V
Output Voltage	V _{REFP}	1.2 V Output, V _{DD} = 3.3 V, T = 25 °C	1.195	1.2	1.205	V
		1.2 V Output	1.18	1.2	1.22	V
		2.4 V Output, V _{DD} = 3.3 V, T = 25 °C	2.39	2.4	2.41	V
		2.4 V Output	2.36	2.4	2.44	V
Turn-on Time, settling to 0.5 LSB	t _{VREFP}	4.7 μF tantalum + 0.1 μF ceramic bypass on VREF pin	_	3	_	ms
		0.1 μF ceramic bypass on VREF pin	_	100	_	μs
Load Regulation	LR _{VREFP}	VREF = 2.4 V, Load = 0 to 200 μA to GND	_	8	_	μV/μΑ
		VREF = 1.2 V, Load = 0 to 200 μA to GND	_	5	_	μV/μΑ
Load Capacitor	C _{VREFP}	Load = 0 to 200 µA to GND	0.1	_	_	μF
Short-circuit current	ISC _{VREFP}		_	_	8	mA
Power Supply Rejection	PSRR _{VRE}		_	75	_	dB
External Reference		1		1	I	
Input Current	I _{EXTREF}	ADC Sample Rate = 1 Msps; VREF = 3.0 V	_	5	_	μА

4.1.11 Temperature Sensor

Table 4.11. Temperature Sensor

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Uncalibrated Offset	V _{OFF}	T _A = 0 °C	_	751	_	mV
Uncalibrated Offset Error ¹	E _{OFF}	T _A = 0 °C	_	19	_	mV
Slope	М		_	2.82	_	mV/°C
Slope Error ¹	E _M		_	29	_	μV/°C
Linearity	LIN	T = 0 °C to 70 °C	_	-0.1 to 0.15	_	°C
		T = -20 °C to 85 °C	_	-0.2 to 0.35	_	°C
		T = -40 °C to 105 °C	_	-0.4 to 0.8	_	°C
Turn-on Time	t _{ON}		_	3.5	_	μs
Temp Sensor Error Using Typical	E _{TOT}	T = 0 °C to 70 °C	-2.6	_	1.8	°C
Slope and Factory-Calibrated Off- set ^{2, 3}		T = -20 °C to 85 °C	-2.9	_	2.7	°C
		T = -40 °C to 105 °C	-3.2	_	4.2	°C

Note:

- 1. Represents one standard deviation from the mean.
- 2. The factory-calibrated offset value is stored in the read-only area of flash in locations 0xFFD4 (low byte) and 0xFFD5 (high byte). The 14-bit result represents the output of the ADC when sampling the temp sensor using the 1.65 V internal voltage reference.
- 3. The temp sensor error includes the offset calibration error, slope error, and linearity error. The values are based upon characterization and are not tested across temperature in production. The values represent three standard deviations above and below the mean. Additional information on achieving high measurement accuracy is available in AN929: Accurate Temperature Sensing with the EFM8 Laser Bee MCU Family.

4.1.12 DACs

Table 4.12. DACs

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Resolution	N _{bits}			12		Bits
Throughput Rate	f _S		_	_	200	ksps
Integral Nonlinearity	INL	DAC0 and DAC2	-10	-1.77 / 1.56	10	LSB
		DAC1 and DAC3	-11.5	-2.73 / 1.11	11.5	LSB
Differential Nonlinearity	DNL		-1	_	1	LSB
Output Noise	VREF = 2.4 V f _S = 0.1 Hz to 300 kHz		_	110	_	μV _{RMS}
Slew Rate	SLEW		_	±1	_	V/µs
Output Settling Time to 1% Full- scale	t _{SETTLE}	V _{OUT} change between 25% and 75% Full Scale	_	2.6	5	μs
Power-on Time	t _{PWR}		_	_	10	μs
Voltage Reference Range	V _{REF}		1.15	_	V _{DD}	V
Power Supply Rejection Ratio	PSRR	DC, V _{OUT} = 50% Full Scale	_	78	_	dB
Total Harmonic Distortion	THD	V _{OUT} = 10 kHz sine wave, 10% to 90%	54	_	_	dB
Offset Error	E _{OFF}	VREF = 2.4 V	-8	0	8	LSB
Full-Scale Error	E _{FS}	VREF = 2.4 V	-13	±5	13	LSB
External Load Impedance	R _{LOAD}		2	_	_	kΩ
External Load Capacitance ¹	C _{LOAD}		_	_	100	pF
Load Regulation		V _{OUT} = 50% Full Scale	_	100	1300	μV/mA
		I _{OUT} = -2 to 2 mA				

Note:

1. No minimum external load capacitance is required. However, under low loading conditions, it is possible for the DAC output to glitch during start-up. If smooth start-up is required, the minimum loading capacitance at the pin should be a minimum of 10 pF.

4.1.13 Comparators

Table 4.13. Comparators

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit
Response Time, CPMD = 00	t _{RESP0}	+100 mV Differential	_	100	_	ns
(Highest Speed)		-100 mV Differential	_	150	_	ns
Response Time, CPMD = 11 (Low-	t _{RESP3}	+100 mV Differential	_	1.5	_	μs
est Power)		-100 mV Differential	_	3.5	_	μs
Positive Hysteresis	HYS _{CP+}	CPHYP = 00	_	0.4	_	mV
Mode 0 (CPMD = 00)		CPHYP = 01	_	8	_	mV
		CPHYP = 10	_	16	_	mV
		CPHYP = 11	_	32	_	mV
Negative Hysteresis	HYS _{CP} -	CPHYN = 00	_	-0.4	_	mV
Mode 0 (CPMD = 00)		CPHYN = 01	_	-8	_	mV
		CPHYN = 10	_	-16	_	mV
		CPHYN = 11	_	-32	_	mV
Positive Hysteresis	HYS _{CP+}	CPHYP = 00	_	0.5	_	mV
Mode 1 (CPMD = 01)		CPHYP = 01	_	6	_	mV
		CPHYP = 10	_	12	_	mV
		CPHYP = 11	_	24	_	mV
Negative Hysteresis	HYS _{CP} -	CPHYN = 00	_	-0.5	_	mV
Mode 1 (CPMD = 01)		CPHYN = 01	_	-6	_	mV
		CPHYN = 10	_	-12	_	mV
		CPHYN = 11	_	-24	_	mV
Positive Hysteresis	HYS _{CP+}	CPHYP = 00	_	0.7	_	mV
Mode 2 (CPMD = 10)		CPHYP = 01	_	4.5	_	mV
		CPHYP = 10	_	9	_	mV
		CPHYP = 11	_	18	_	mV
Negative Hysteresis	HYS _{CP} -	CPHYN = 00	_	-0.6	_	mV
Mode 2 (CPMD = 10)		CPHYN = 01	_	-4.5	_	mV
		CPHYN = 10	_	-9	_	mV
		CPHYN = 11	_	-18	_	mV
Positive Hysteresis	HYS _{CP+}	CPHYP = 00	_	1.5	_	mV
Mode 3 (CPMD = 11)		CPHYP = 01	_	4	_	mV
		CPHYP = 10	_	8	_	mV
		CPHYP = 11	_	16	_	mV

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
15	P2.2	Multifunction I/O	Yes	P2MAT.2	ADC0.15
				CLU2OUT	CMP1P.4
				CLU1A.15	CMP1N.4
				CLU2B.14	
				CLU3A.14	
16	P2.1	Multifunction I/O	Yes	P2MAT.1	ADC0.14
				12C0_SCL	CMP1P.3
				CLU1B.14	CMP1N.3
				CLU2A.15	
				CLU3B.15	
17	P2.0	Multifunction I/O	Yes	P2MAT.0	CMP1P.2
				I2C0_SDA	CMP1N.2
				CLU1A.14	
				CLU2A.14	
				CLU3B.14	
18	P1.7	Multifunction I/O	Yes	P1MAT.7	ADC0.13
				CLU0B.15	CMP0P.9
				CLU1B.13	CMP0N.9
				CLU2A.13	
19	P1.6	Multifunction I/O	Yes	P1MAT.6	ADC0.12
				CLU0A.15	
				CLU1B.12	
				CLU2A.12	
20	P1.5	Multifunction I/O	Yes	P1MAT.5	ADC0.11
				CLU0B.14	
				CLU1A.13	
				CLU2B.13	
21	P1.4	Multifunction I/O	Yes	P1MAT.4	ADC0.10
				CLU0A.14	
				CLU1A.12	
				CLU2B.12	
22	P1.3	Multifunction I/O	Yes	P1MAT.3	ADC0.9
				CLU0B.13	
				CLU1B.11	
				CLU2B.11	
				CLU3A.13	

Pin Number	Pin Name	Description	Crossbar Capability	Additional Digital Functions	Analog Functions
30	P0.3	Multifunction I/O	Yes	P0MAT.3	XTAL2
				EXTCLK	
				INT0.3	
				INT1.3	
				CLU0B.9	
				CLU2B.9	
				CLU3A.9	
31	P0.2	Multifunction I/O	Yes	P0MAT.2	XTAL1
				INT0.2	ADC0.1
				INT1.2	CMP0P.1
				CLU0OUT	CMP0N.1
				CLU0A.9	
				CLU2B.8	
				CLU3A.8	
32	P0.1	Multifunction I/O	Yes	P0MAT.1	ADC0.0
				INT0.1	CMP0P.0
				INT1.1	CMP0N.0
				CLU0B.8	AGND
				CLU2A.9	
				CLU3B.9	

6.3 EFM8LB1x-QFN24 Pin Definitions

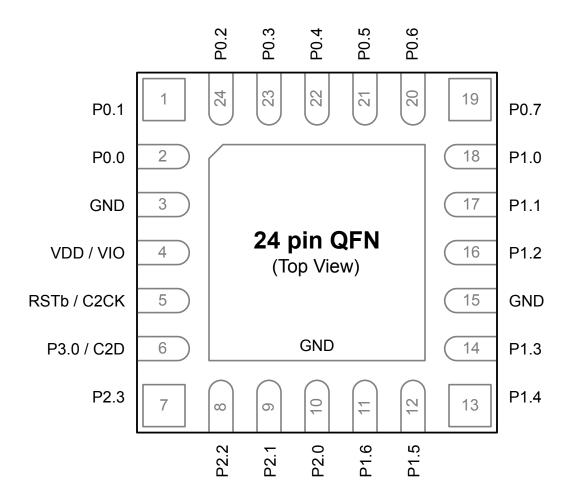


Figure 6.3. EFM8LB1x-QFN24 Pinout

Table 6.3. Pin Definitions for EFM8LB1x-QFN24

Pin	Pin Name	Description	Crossbar Capability	Additional Digital	Analog Functions
Number				Functions	
1	P0.1	Multifunction I/O	Yes	P0MAT.1	ADC0.0
				INT0.1	CMP0P.0
				INT1.1	CMP0N.0
				CLU0B.8	AGND
				CLU2A.9	
				CLU3B.9	

Dimension Min Max

Note:

- 1. All dimensions shown are in millimeters (mm) unless otherwise noted.
- 2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
- 3. This Land Pattern Design is based on the IPC-7351 guidelines.
- 4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05mm.
- 5. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 μm minimum, all the way around the pad.
- 6. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
- 7. The stencil thickness should be 0.125 mm (5 mils).
- 8. The ratio of stencil aperture to land pad size should be 1:1 for all perimeter pads.
- 9. A 2 x 2 array of 1.10 mm square openings on a 1.30 mm pitch should be used for the center pad.
- 10. A No-Clean, Type-3 solder paste is recommended.
- 11. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.

7.3 QFN32 Package Marking



Figure 7.3. QFN32 Package Marking

The package marking consists of:

- PPPPPPP The part number designation.
- TTTTTT A trace or manufacturing code.
- YY The last 2 digits of the assembly year.
- WW The 2-digit workweek when the device was assembled.
- # The device revision (A, B, etc.).

8. QFP32 Package Specifications

8.1 QFP32 Package Dimensions

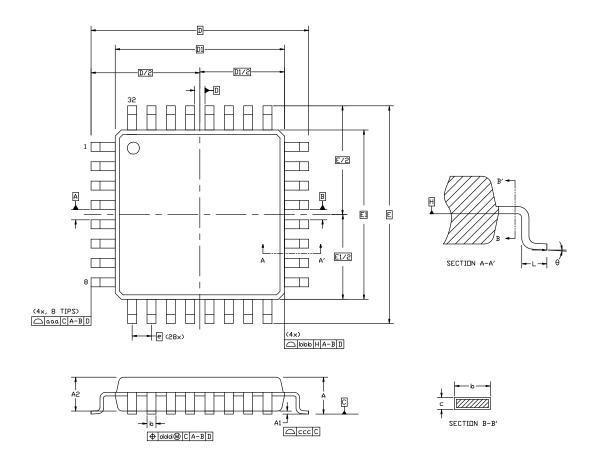


Figure 8.1. QFP32 Package Drawing

Table 8.1. QFP32 Package Dimensions

Dimension	Min	Тур	Max
Α	_	_	1.20
A1	0.05	_	0.15
A2	0.95	1.00	1.05
b	0.30	0.37	0.45
С	0.09	_	0.20
D	9.00 BSC		
D1	7.00 BSC		
е	0.80 BSC		
Е	9.00 BSC		
E1	7.00 BSC		
L	0.50	0.60	0.70

8.3 QFP32 Package Marking

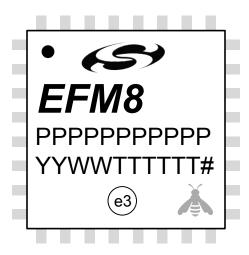


Figure 8.3. QFP32 Package Marking

The package marking consists of:

- PPPPPPP The part number designation.
- TTTTTT A trace or manufacturing code.
- YY The last 2 digits of the assembly year.
- WW The 2-digit workweek when the device was assembled.
- # The device revision (A, B, etc.).

11. Revision History

11.1 Revision 1.01

October 21st, 2016

Updated QFN24 center pad stencil description.

11.2 Revision 1.0

September 6th, 2016

Updated part numbers to revision B.

Updated many specifications with full characterization data.

Added a note regarding which DACs are available to Table 2.1 Product Selection Guide on page 2.

Added specifications for 4.1.16 SMBus.

Added bootloader pinout information to 3.10 Bootloader.

Added CRC Calculation Time to 4.1.4 Flash Memory.

11.3 Revision 0.5

February 10th, 2016

Updated Figure 5.2 Debug Connection Diagram on page 32 to move the pull-up resistor on C2D / RSTb to after the series resistor instead of before.

Added S0 devices and information about the SMBus bootloader in 3.10 Bootloader.

Added a reference to AN945: EFM8 Factory Bootloader User Guide in 3.10 Bootloader.

Added mention of the pre-programmed bootloaders in 1. Feature List.

Updated all part numbers to revision B.

Added the C oscillator, which is now available on revision B.

Adjusted C1, C2, X2, Y2, and Y1 maximums for 7.2 QFN32 PCB Land Pattern.

Adjusted package markings for QFN32 and QSOP24 packages.

Filled in TBD minimum and maximum values for DAC Differential Nonlinearity in Table 4.12 DACs on page 24.

11.4 Revision 0.4

Updated specification tables based on current device characterization status and production test limits.

Added bootloader section.

Added typical connection diagrams.

Corrected CLU connections in pin function tables.

11.5 Revision 0.3

Added information on the bootloader to 3.10 Bootloader.

Updated some characterization TBD values.

11.6 Revision 0.1

Initial release.

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